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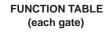
 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These devices contain four independent 2-input exclusive-OR gates. They perform the Boolean function $Y = A \oplus B$ or $Y = \overline{AB} + A\overline{B}$ in positive logic.

A common application is as a true/complement element. If one of the inputs is low, the other input is reproduced in true form at the output. If one of the inputs is high, the signal on the other input is reproduced inverted at the output.

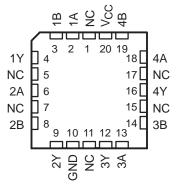
The SN54F86 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74F86 is characterized for operation from 0°C to 70°C.



INP	UTS	OUTPUT				
Α	В	Y				
L	L	L				
L	Н	н				
н	L	н				
н	Н	L				

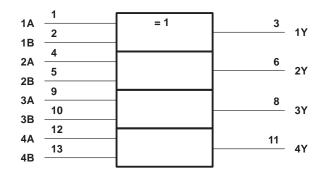
SN54F86 ... J PACKAGE SN74F86 ... D OR N PACKAGE (TOP VIEW) 14 🛛 V_{CC} 1A 1B [4B 13 2 1Y Π 12 4A 3 2A [11 4Y 4 2В П 10 3B 5 2Y 6 9 3A 3Y GND 7 8

SN54F86 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.



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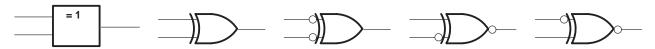
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exclusive-OR logic

An exclusive-OR gate has many applications, some of which can be represented better by alternative logic symbols.

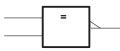
EXCLUSIVE OR

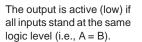


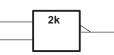
These are five equivalent exclusive-OR symbols valid for an 'F86 gate in positive logic; negation may be shown at any two ports.

LOGIC-IDENTITY ELEMENT

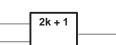
EVEN-PARITY ELEMENT







The output is active (low) if an even number of inputs (i.e., 0 or 2) are active.



ODD-PARITY ELEMENT

The output is active (high) if an odd number of outputs (i.e., only 1 of the 2) are active.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, VI (see Note 1)	–1.2 V to 7 V
Input current range	–30 mA to 5 mA
Voltage range applied to any output in the high state	–0.5 V to V _{CC}
Current into any output in the low state	40 mA
Package thermal impedance, θ_{JA} (see Note 2): D package	127°C/W
N package	78°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input voltage ratings may be exceeded provided the input current ratings are observed.
 - 2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

		SN54F86			SN74F86			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
Iк	Input clamp current			-18			-18	mA
ЮН	High-level output current			-1			-1	mA
I _{OL}	Low-level output current			20			20	mA
ТА	Operating free-air temperature	-55		125	0		70	°C



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS			SN54F86			SN74F86		
			MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK	V _{CC} = 4.5 V,	lj = -18 mA			-1.2			-1.2	V
	V _{CC} = 4.5 V,	I _{OH} = -1 mA	2.5	3.4		2.5	3.4		V
VOH	V _{CC} = 4.75 V,	I _{OH} = -1 mA				2.7			v
V _{OL}	V _{CC} = 4.5 V,	I _{OL} = 20 mA		0.3	0.5		0.3	0.5	V
lj	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
ΙIΗ	V _{CC} = 5.5 V,	VI = 2.7 V			20			20	μA
١ _{١L}	V _{CC} = 5.5 V,	V _I = 0.5 V			- 0.6			- 0.6	mA
los‡	V _{CC} = 5.5 V,	$V_{O} = 0$	-60		-150	-60		-150	mA
ІССН	V _{CC} = 5.5 V,	See Note 3		15	23		15	23	mA
ICCL	V _{CC} = 5.5 V,	V _I = 4.5 V		18	28		18	28	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡]Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second. NOTE 3: I_{CCH} is measured with outputs open, and the A or B input (not both) at 4.5 V. Remaining inputs are grounded.

switching characteristics (see Figure 1)

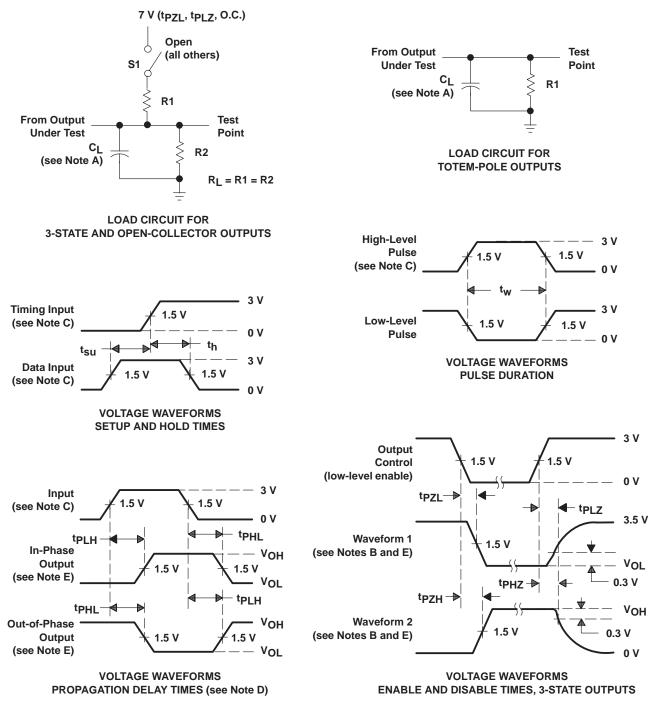
PARAMETER	METER FROM TO (INPUT) (OUTPUT)		V _{CC} = 5 V, C _L = 50 pF, R _L = 500 Ω, T _A = 25°C ′F86		$V_{CC} = 4.5 V \text{ to } 5.5 V,$ $C_{L} = 50 \text{ pF},$ $R_{L} = 500\Omega,$ $T_{A} = \text{MIN to MAX}$ $SN54F86 \qquad SN74F86$				UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
^t PLH	A or B (other input low)	Y Y	3	4	5.5	3	7	3	6.5	
^t PHL			3	4.2	5.5	2.6	8	3	6.5	ns
^t PLH	A or B (other input high)	v	3.5	5.3	7	3.5	10	3.5	8	ns
^t PHL			3	4.7	6.5	3	8	3	7.5	115

§ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



SN54F86, SN74F86 QUADRUPLE 2-INPUT EXCLUSIVE-OR GATES

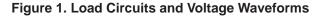
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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
- Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: $PRR \le 1$ MHz, $t_r = t_f \le 2.5$ ns, duty cycle = 50%.
- D. When measuring propagation delay times of 3-state outputs, switch S1 is open.
- E. The outputs are measured one at a time with one transition per measurement.





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